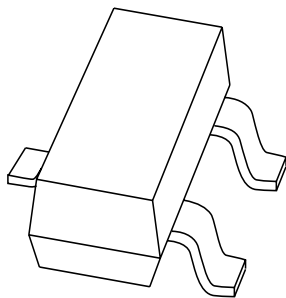


DATA SHEET



PBSS5350T

50 V, 3 A

PNP low V_{CEsat} (BISS) transistor

Product data sheet
Supersedes data of 2002 Aug 08

2004 Jan 13

50 V, 3 A

PNP low V_{CEsat} (BISS) transistor

PBSS5350T**FEATURES**

- Low collector-emitter saturation voltage V_{CEsat} and corresponding low R_{CEsat}
- High collector current capability
- High collector current gain
- Improved efficiency due to reduced heat generation.

APPLICATIONS

- Power management applications
- Low and medium power DC/DC convertors
- Supply line switching
- Battery chargers
- Linear voltage regulation with low voltage drop-out (LDO).

DESCRIPTION

PNP low V_{CEsat} transistor in a SOT23 plastic package.
NPN complement: PBSS4350T.

MARKING

TYPE NUMBER	MARKING CODE ⁽¹⁾
PBSS5350T	ZD*

Note

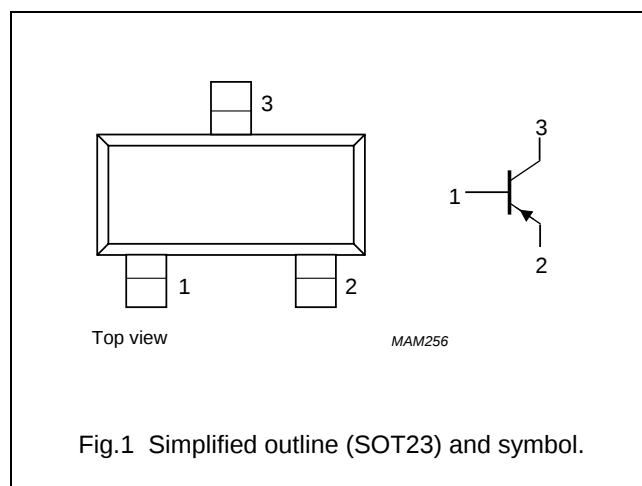
- * = p: Made in Hong Kong.
* = t: Made in Malaysia.
* = W: Made in China.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V_{CEO}	collector-emitter voltage	-50	V
I_C	collector current (DC)	-2	A
I_{CRP}	repetitive peak collector current	-3	A
R_{CEsat}	equivalent on-resistance	135	mΩ

PINNING

PIN	DESCRIPTION
1	base
2	emitter
3	collector

**ORDERING INFORMATION**

TYPENUMBER	PACKAGE		
	NAME	DESCRIPTION	VERSION
PBSS5350T	—	plastic surface mounted package; 3 leads	SOT23

50 V, 3 A PNP low V_{CEsat} (BISS) transistor

PBSS5350T

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CBO}	collector-base voltage	open emitter	–	–50	V
V_{CEO}	collector-emitter voltage	open base	–	–50	V
V_{EBO}	emitter-base voltage	open collector	–	–5	V
I_C	collector current (DC)		–	–2	A
I_{CRP}	repetitive peak collector current	note 1	–	–3	A
I_{CM}	peak collector current	single peak	–	–5	A
I_B	base current (DC)		–	–0.5	A
P_{tot}	total power dissipation	$T_{amb} \leq 25\text{ °C}$; note 2	–	300	mW
		$T_{amb} \leq 25\text{ °C}$; note 3	–	480	mW
		$T_{amb} \leq 25\text{ °C}$; note 4	–	540	mW
		$T_{amb} \leq 25\text{ °C}$; notes 1 and 2	–	1.2	W
T_{stg}	storage temperature		–65	+150	°C
T_j	junction temperature		–	150	°C
T_{amb}	operating ambient temperature		–65	+150	°C

Notes

- Operated under pulsed conditions: pulse width $t_p \leq 100\text{ ms}$; duty cycle $\delta \leq 0.25$.
- Device mounted on a printed-circuit board; single sided copper; tinplated; standard footprint.
- Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 1 cm^2 .
- Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 6 cm^2 .

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air; note 1	417	K/W
		in free air; note 2	260	K/W
		in free air; note 3	230	K/W
		in free air; notes 1 and 4	104	K/W

Notes

- Device mounted on a printed-circuit board; single sided copper; tinplated; standard footprint.
- Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 1 cm^2 .
- Device mounted on a printed-circuit board; single sided copper; tinplated; mounting pad for collector 6 cm^2 .
- Operated under pulsed conditions: pulse width $t_p \leq 100\text{ ms}$; duty cycle $\delta \leq 0.25$.

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CHARACTERISTICS

$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

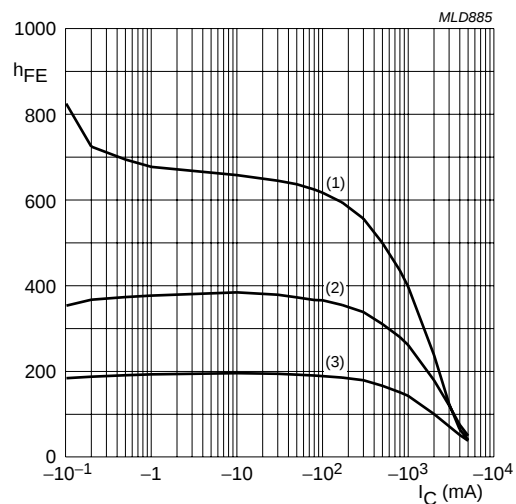
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{CBO}	collector-base cut-off current	$V_{CB} = -50\text{ V}; I_E = 0$	—	—	−100	nA
		$V_{CB} = -50\text{ V}; I_E = 0; T_j = 150\text{ }^{\circ}\text{C}$	—	—	−50	μA
I_{EBO}	emitter-base cut-off current	$V_{EB} = -5\text{ V}; I_C = 0$	—	—	−100	nA
h_{FE}	DC current gain	$V_{CE} = -2\text{ V}; I_C = -100\text{ mA}$	200	—	—	
		$V_{CE} = -2\text{ V}; I_C = -500\text{ mA}$	200	—	—	
		$V_{CE} = -2\text{ V}; I_C = -1\text{ A}; \text{note 1}$	200	—	—	
		$V_{CE} = -2\text{ V}; I_C = -2\text{ A}; \text{note 1}$	130	—	—	
		$V_{CE} = -2\text{ V}; I_C = -3\text{ A}; \text{note 1}$	80	—	—	
V_{CEsat}	collector-emitter saturation voltage	$I_C = -500\text{ mA}; I_B = -50\text{ mA}$	—	—	−90	mV
		$I_C = -1\text{ A}; I_B = -50\text{ mA}$	—	—	−180	mV
		$I_C = -2\text{ A}; I_B = -100\text{ mA}; \text{note 1}$	—	—	−320	mV
		$I_C = -2\text{ A}; I_B = -200\text{ mA}; \text{note 1}$	—	—	−270	mV
		$I_C = -3\text{ A}; I_B = -300\text{ mA}; \text{note 1}$	—	—	−390	mV
R_{CEsat}	equivalent on-resistance	$I_C = -2\text{ A}; I_B = -200\text{ mA}; \text{note 1}$	—	90	135	$\text{m}\Omega$
V_{BEsat}	base-emitter saturation voltage	$I_C = -2\text{ A}; I_B = -100\text{ mA}; \text{note 1}$	—	—	−1.1	V
		$I_C = -3\text{ A}; I_B = -300\text{ mA}; \text{note 1}$	—	—	−1.2	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -2\text{ V}; I_C = -1\text{ A}; \text{note 1}$	−1.2	—	—	V
f_T	transition frequency	$I_C = -100\text{ mA}; V_{CE} = -5\text{ V};$ $f = 100\text{ MHz}$	100	—	—	MHz
C_c	collector capacitance	$V_{CB} = -10\text{ V}; I_E = I_C = 0; f = 1\text{ MHz}$	—	—	35	pF

Note

1. Pulse test: $t_p \leq 300\text{ }\mu\text{s}$; $\delta \leq 0.02$.

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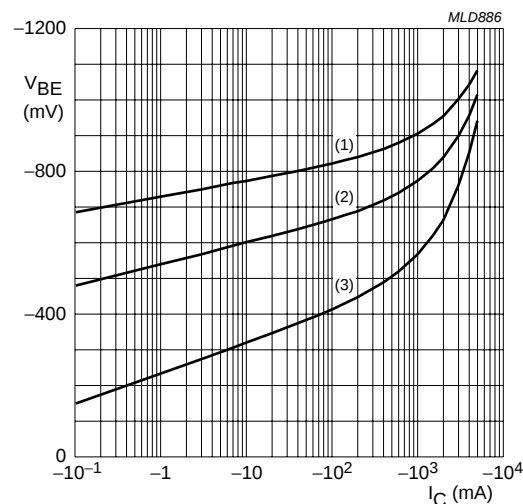
$V_{CE} = -2$ V.

(1) $T_{amb} = 150$ °C.

(2) $T_{amb} = 25$ °C.

(3) $T_{amb} = -55$ °C.

Fig.2 DC current gain as a function of collector current; typical values.



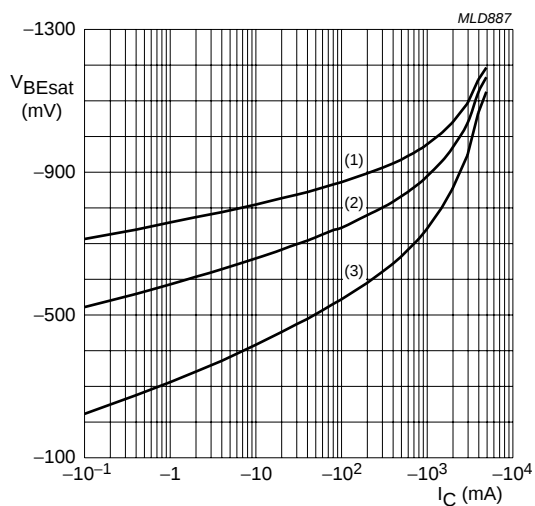
$V_{CE} = -2$ V.

(1) $T_{amb} = -55$ °C.

(2) $T_{amb} = 25$ °C.

(3) $T_{amb} = 150$ °C.

Fig.3 Base-emitter voltage as a function of collector current; typical values.



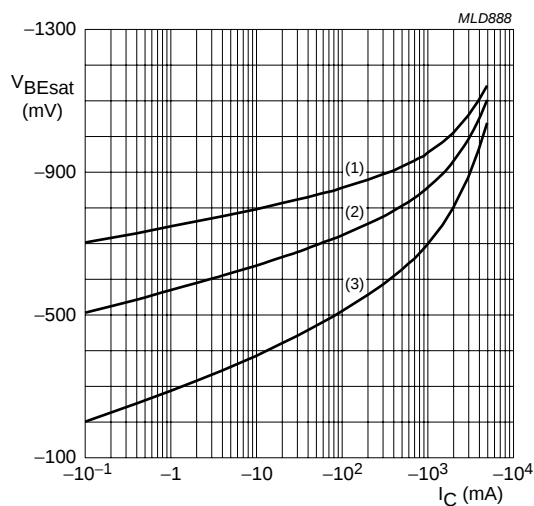
$I_C/I_B = 10$.

(1) $T_{amb} = -55$ °C.

(2) $T_{amb} = 25$ °C.

(3) $T_{amb} = 150$ °C.

Fig.4 Base-emitter saturation voltage as a function of collector current; typical values.



$I_C/I_B = 20$.

(1) $T_{amb} = -55$ °C.

(2) $T_{amb} = 25$ °C.

(3) $T_{amb} = 150$ °C.

Fig.5 Base-emitter saturation voltage as a function of collector current; typical values.

50 V, 3 A PNP low V_{CEsat} (BISS) transistor

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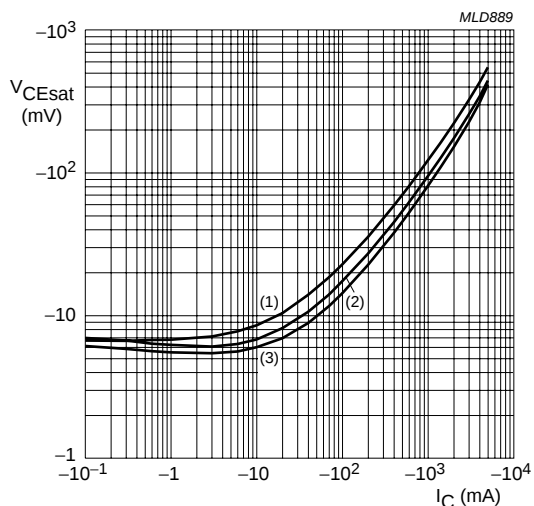
 $I_C/I_B = 10$.(1) $T_{amb} = 150\text{ °C}$.(2) $T_{amb} = 25\text{ °C}$.(3) $T_{amb} = -55\text{ °C}$.

Fig.6 Collector-emitter saturation voltage as a function of collector current; typical values.

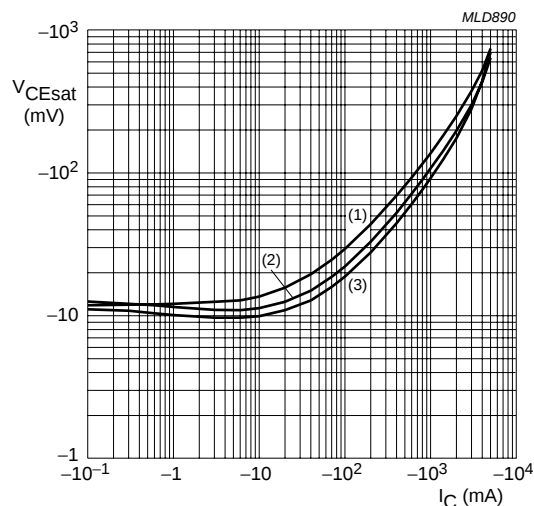
 $I_C/I_B = 20$.(1) $T_{amb} = 150\text{ °C}$.(2) $T_{amb} = 25\text{ °C}$.(3) $T_{amb} = -55\text{ °C}$.

Fig.7 Collector-emitter saturation voltage as a function of collector current; typical values.

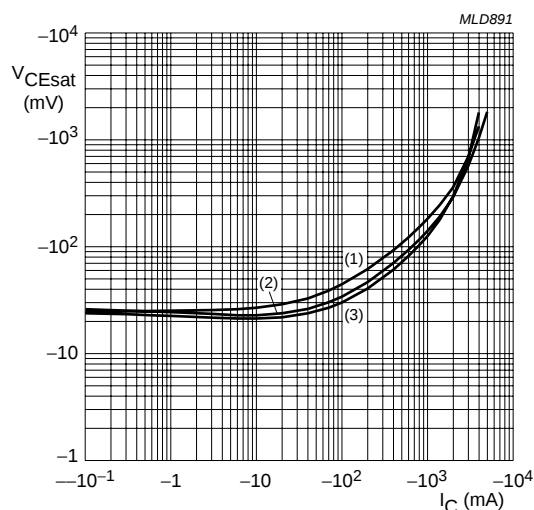
 $I_C/I_B = 50$.(1) $T_{amb} = 150\text{ °C}$.(2) $T_{amb} = 25\text{ °C}$.(3) $T_{amb} = -55\text{ °C}$.

Fig.8 Collector-emitter saturation voltage as a function of collector current; typical values.

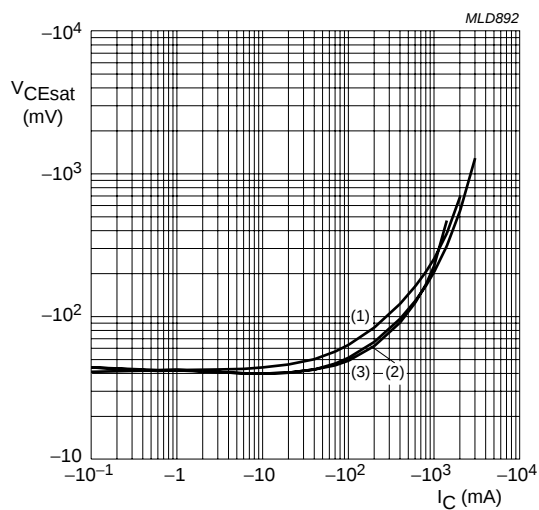
 $I_C/I_B = 100$.(1) $T_{amb} = 150\text{ °C}$.(2) $T_{amb} = 25\text{ °C}$.(3) $T_{amb} = -55\text{ °C}$.

Fig.9 Collector-emitter saturation voltage as a function of collector current; typical values.

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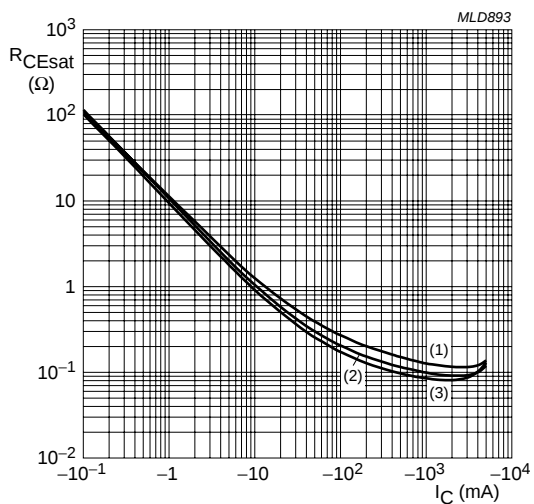
 $I_C/I_B = 20$.(1) $T_{amb} = 150\text{ }^{\circ}\text{C}$.(2) $T_{amb} = 25\text{ }^{\circ}\text{C}$.(3) $T_{amb} = -55\text{ }^{\circ}\text{C}$.

Fig.10 Equivalent on-resistance as a function of collector current; typical values.

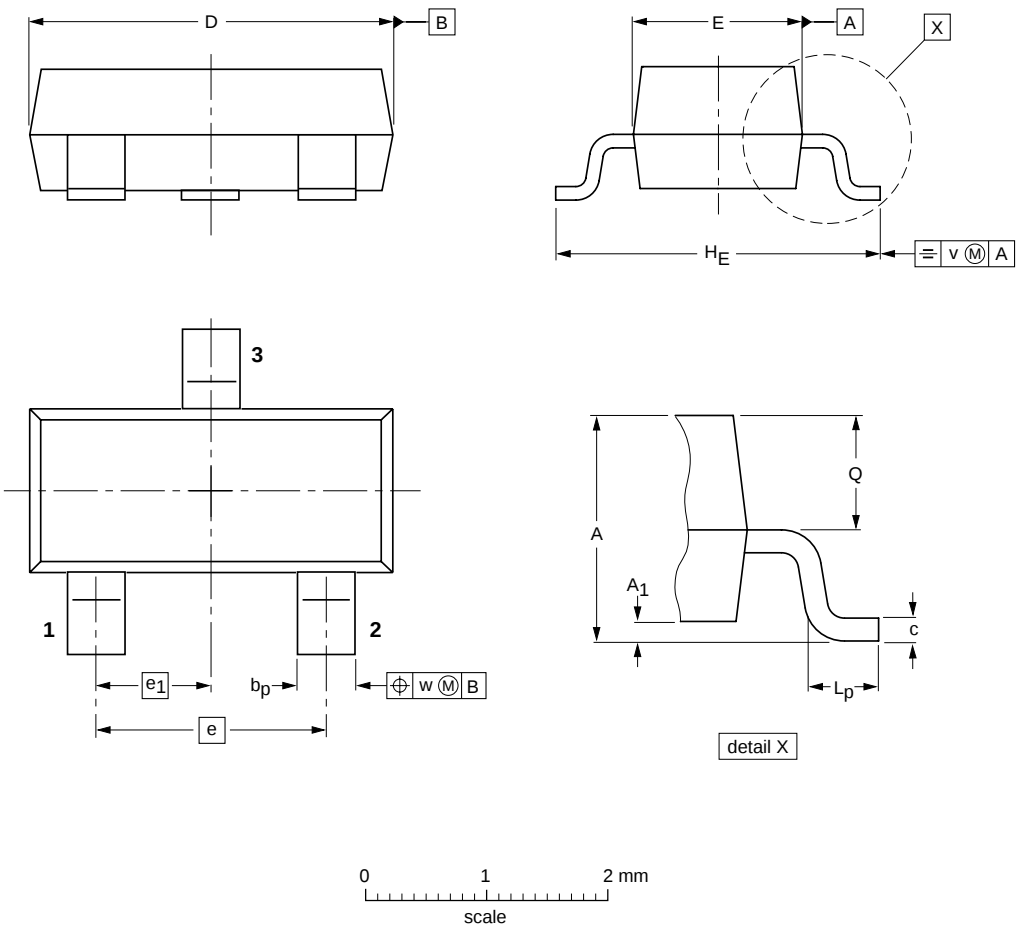
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PACKAGE OUTLINE

Plastic surface-mounted package; 3 leads

SOT23



DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁ max.	b _p	c	D	E	e	e ₁	H _E	L _p	Q	v	w
mm	1.1 0.9	0.1	0.48 0.38	0.15 0.09	3.0 2.8	1.4 1.2	1.9	0.95	2.5 2.1	0.45 0.15	0.55 0.45	0.2	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT23		TO-236AB				04-11-04 06-03-16